## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | VEERARAGHAVAN ET AL. | Examiner | Art Unit | Muktesh G. Gupta | 2444 | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0010798 A1	01-2002	Ben-Shaul et al.	709/247
*	В	US-6,460,141 B1	10-2002	Olden, Eric M.	726/4
*	C	US-2003/0028451 A1	02-2003	Ananian, John Allen	705/27
*	D	US-2003/0101451 A1	05-2003	Bentolila et al.	725/34
*	Е	US-2003/0120593 A1	06-2003	Bansal et al.	705/39
*	F	US-2003/0208505 A1	11-2003	Mullins et al.	707/102
*	G	US-2004/0088348 A1	05-2004	Yeager et al.	709/202
*	Ι	US-2006/0140134 A1	06-2006	O'Brien et al.	370/252
	-	US-			
	J	US-			
	K	US-			
	L	US-			
_	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.